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## MC10E446, MC100E446

## 5V ECL 4-Bit Parallel/Serial Converter

## Description

The MC10E/100E446 is an integrated 4-bit parallel to serial data converter. The device is designed to operate for NRZ data rates of up to $1.3 \mathrm{~Gb} / \mathrm{s}$. The chip generates a divide by 4 and a divide by 8 clock for both 4-bit conversion and a two chip 8-bit conversion function. The conversion sequence was chosen to convert the parallel data into a serial stream from bit D0 to D3. A serial input is provided to cascade two E446 devices for 8 bit conversion applications. Note that the serial output data clocks off of the negative input clock transition.

The SYNC input will asynchronously reset the internal clock circuitry. This pin allows the user to reset the internal clock conversion unit and thus select the start of the conversion process.

The MODE input is used to select the conversion mode of the device. With the MODE input LOW, or open, the device will function as a 4-bit converter. When the mode input is driven HIGH the internal load clock will change on every eighth clock cycle thus allowing for an 8-bit conversion scheme using two E446's. When cascaded in an 8-bit conversion scheme the devices will not operate at the $1.3 \mathrm{~Gb} / \mathrm{s}$ data rate of a single device. Refer to the applications section of this data sheet for more information on cascading the E446.

The $\mathrm{V}_{\mathrm{BB}}$ pin, an internally generated voltage supply, is available to this device only. For single-ended input conditions, the unused differential input is connected to $\mathrm{V}_{\mathrm{BB}}$ as a switching reference voltage. $\mathrm{V}_{\mathrm{BB}}$ may also rebias AC coupled inputs. When used, decouple $\mathrm{V}_{\mathrm{BB}}$ and $\mathrm{V}_{\mathrm{CC}}$ via a $0.01 \mu \mathrm{~F}$ capacitor and limit current sourcing or sinking to 0.5 mA . When not used, $\mathrm{V}_{\mathrm{BB}}$ should be left open.

The 100 Series contains temperature compensation.

## Features

- On Chip Clock $\div 4$ and $\div 8$
- $1.5 \mathrm{~Gb} / \mathrm{s}$ Typical Data Rate Capability
- Differential Clock and Serial Inputs
- $V_{B B}$ Output for Single-ended Input Applications
- Asynchronous Data Synchronization
- Mode Select to Expand to 8 Bits
- PECL Mode Operating Range: $\mathrm{V}_{\mathrm{CC}}=4.2 \mathrm{~V}$ to 5.7 V with $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$
- NECL Mode Operating Range: $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V}$ with $\mathrm{V}_{\mathrm{EE}}=-4.2 \mathrm{~V}$ to -5.7 V
- Internal Input $50 \mathrm{k} \Omega$ Pulldown Resistors
- ESD Protection: Human Body Model; > 2 kV , Machine Model; > 100 V

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## ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 10 of this data sheet.

- Meets or Exceeds JEDEC Spec EIA/JESD78 IC Latchup Test
- Flammability Rating: UL 94 V-0 @ 0.125 in, Oxygen Index: 28 to 34
- Transistor Count $=525$ devices
- Moisture Sensitivity Level: $\mathrm{Pb}=1 ; \mathrm{Pb}-$ Free $=3$ For Additional Information, see Application Note AND8003/D
- $\mathrm{Pb}-$ Free Packages are Available*

[^0]
## MC10E446, MC100E446



Table 1. PIN DESCRIPTION

| PIN | FUNCTION |
| :--- | :--- |
| SIN | ECL Differential Serial Data Input |
| D0 - D3 | ECL Parallel Data Inputs |
| SOUT, SOUT | ECL Differential Serial Data Output |
| CLK, CLK | ECL Differential Clock Inputs |
| CL/4, CL/4 | ECL Differential $\div 4$ Clock Output |
| CL/8, CL/8 | ECL Differential $\div 8$ Clock Output |
| MODE | Conversion Mode 4-Bit/8-Bit |
| SYNC | ECL Conversion Synchronizing Input |
| VBB $^{\text {Reference Voltage Output }}$ |  |
| V $_{\text {CC }}, V_{\text {CCO }}$ | Positive Supply |
| VEE $^{\text {NC }}$ | Negative Supply |
|  | No Connect |



Figure 2. Logic Diagram

Table 2. FUNCTION TABLES

| Mode | Conversion |
| :---: | :---: |
| L | 4-Bit |
| H | 8-Bit |

Table 3. MAXIMUM RATINGS

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {CC }}$ | PECL Mode Power Supply | $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$ |  | 8 | V |
| $\mathrm{V}_{1}$ | PECL Mode Input Voltage NECL Mode Input Voltage | $\begin{aligned} & \mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{CC}}=0 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{I}} \leq \mathrm{V}_{\mathrm{CC}} \\ & \mathrm{~V}_{\mathrm{I}} \geq \mathrm{V}_{\mathrm{EE}} \end{aligned}$ | $\begin{gathered} \hline 6 \\ -6 \end{gathered}$ | $\begin{aligned} & \mathrm{V} \\ & \mathrm{v} \end{aligned}$ |
| $\mathrm{I}_{\text {out }}$ | Output Current | Continuous Surge |  | $\begin{gathered} 50 \\ 100 \end{gathered}$ | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \end{aligned}$ |
| $\mathrm{I}_{\mathrm{BB}}$ | $\mathrm{V}_{\text {BB }}$ Sink/Source |  |  | $\pm 0.5$ | mA |
| $\mathrm{T}_{\text {A }}$ | Operating Temperature Range |  |  | 0 to +85 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ | Storage Temperature Range |  |  | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |
| $\theta_{\mathrm{JA}}$ | Thermal Resistance (Junction-to-Ambient) | $\begin{aligned} & 0 \text { Ifpm } \\ & 500 \text { lfpm } \end{aligned}$ | $\begin{aligned} & \text { PLCC-28 } \\ & \text { PLCC-28 } \end{aligned}$ | $\begin{aligned} & 63.5 \\ & 43.5 \end{aligned}$ | $\begin{aligned} & { }^{\circ} \mathrm{C} / \mathrm{W} \\ & { }^{\circ} \mathrm{C} / \mathrm{W} \end{aligned}$ |
| $\theta_{\text {Jc }}$ | Thermal Resistance (Junction-to-Case) | Standard Board | PLCC-28 | 22 to 26 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{T}_{\text {sol }}$ | Wave SolderPb <br> $\mathrm{Pb}-\mathrm{Free}$ |  |  | $\begin{aligned} & 265 \\ & 265 \end{aligned}$ | ${ }^{\circ} \mathrm{C}$ |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

Table 4. 10E SERIES PECL DC CHARACTERISTICS $\mathrm{V}_{\mathrm{CCx}}=5.0 \mathrm{~V}$; $\mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}$ (Note 1)

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 126 | 151 |  | 126 | 151 |  | 126 | 151 | mA |
| $\mathrm{V}_{\text {OH }}$ | Output HIGH Voltage (Note 2) | 3980 | 4070 | 4160 | 4020 | 4105 | 4190 | 4090 | 4185 | 4280 | mV |
| $\mathrm{VOH}_{\text {SOUT }}$ | Output HIGH Voltage SOUT/SOUT | 3980 |  | 4210 | 4020 |  | 4240 | 4090 |  | 4330 | mV |
| $\mathrm{V}_{\mathrm{OL}}$ | Output LOW Voltage (Note 2) | 3050 | 3210 | 3370 | 3050 | 3210 | 3370 | 3050 | 3227 | 3405 | mV |
| $\mathrm{V}_{1 \mathrm{H}}$ | Input HIGH Voltage | 3830 | 3995 | 4160 | 3870 | 4030 | 4190 | 3940 | 4110 | 4280 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage | 3050 | 3285 | 3520 | 3050 | 3285 | 3520 | 3050 | 3302 | 3555 | mV |
| $\mathrm{V}_{\mathrm{BB}}$ | Output Voltage Reference | 3.62 |  | 3.74 | 3.65 |  | 3.75 | 3.69 |  | 3.81 | V |
| $\mathrm{I}_{\mathrm{IH}}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {IL }}$ | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.3 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 5. 10E SERIES NECL DC CHARACTERISTICS $\mathrm{V}_{\mathrm{CCx}}=0.0 \mathrm{~V}$; $\mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}$ (Note 3)

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 126 | 151 |  | 126 | 151 |  | 126 | 151 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 4) | -1020 | -930 | -840 | -980 | -895 | -810 | -910 | -815 | -720 | mV |
| $\mathrm{VOH}_{\text {SOUT }}$ | Output HIGH Voltage SOUT/SOUT | -1020 |  | -790 | -980 |  | -760 | -910 |  | -670 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 4) | -1950 | -1790 | -1630 | -1950 | -1790 | -1630 | -1950 | -1773 | -1595 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | -1170 | -1005 | -840 | -1130 | -970 | -810 | -1060 | -890 | -720 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage | -1950 | -1715 | -1480 | -1950 | -1715 | -1480 | -1950 | -1698 | -1445 | mV |
| $\mathrm{V}_{\text {BB }}$ | Output Voltage Reference | -1.38 |  | -1.27 | -1.35 |  | -1.25 | -1.31 |  | -1.19 | V |
| $\mathrm{I}_{\mathrm{IH}}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {IL }}$ | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.065 |  | 0.3 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm . Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.
3. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.
4. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 6. 100E SERIES PECL DC CHARACTERISTICS $\mathrm{V}_{\mathrm{CCx}}=5.0 \mathrm{~V}$; $\mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}$ (Note 5)

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 126 | 151 |  | 126 | 151 |  | 145 | 174 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 6) | 3975 | 4050 | 4120 | 3975 | 4050 | 4120 | 3975 | 4050 | 4120 | mV |
| $\mathrm{VOH}_{\text {SOUT }}$ | Output HIGH Voltage SOUT/SOUT | 3975 |  | 4170 | 3975 |  | 4170 | 3975 |  | 4170 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 6) | 3190 | 3295 | 3380 | 3190 | 3255 | 3380 | 3190 | 3260 | 3380 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | 3835 | 3975 | 4120 | 3835 | 3975 | 4120 | 3835 | 3975 | 4120 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage | 3190 | 3355 | 3525 | 3190 | 3355 | 3525 | 3190 | 3355 | 3525 | mV |
| $\mathrm{V}_{\text {BB }}$ | Output Voltage Reference | 3.62 |  | 3.73 | 3.62 |  | 3.74 | 3.62 |  | 3.74 | V |
| $\mathrm{I}_{\mathrm{IH}}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.5 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm . Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.
5. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
6. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 7. 100E SERIES NECL DC CHARACTERISTICS $\mathrm{V}_{\mathrm{CCx}}=0.0 \mathrm{~V}$; $\mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}$ (Note 7)

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 126 | 151 |  | 126 | 151 |  | 145 | 174 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 8) | -1025 | -950 | -880 | -1025 | -950 | -880 | -1025 | -950 | -880 | mV |
| $\mathrm{VOH}_{\text {SOUT }}$ | Output HIGH Voltage SOUT/SOUT | -1025 |  | -830 | -1025 |  | -830 | -1025 |  | -830 | mV |
| $\mathrm{V}_{\mathrm{OL}}$ | Output LOW Voltage (Note 8) | -1810 | -1705 | -1620 | -1810 | -1745 | -1620 | -1810 | -1740 | -1620 | mV |
| $\mathrm{V}_{\text {IH }}$ | Input HIGH Voltage | -1165 | -1025 | -880 | -1165 | -1025 | -880 | -1165 | -1025 | -880 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage | -1810 | -1645 | -1475 | -1810 | -1645 | -1475 | -1810 | -1645 | -1475 | mV |
| $\mathrm{V}_{\mathrm{BB}}$ | Output Voltage Reference | -1.38 |  | -1.27 | -1.38 |  | -1.26 | -1.38 |  | -1.26 | V |
| $\mathrm{I}_{\mathrm{H}}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {IL }}$ | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.5 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm . Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.
7. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
8. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 8. AC CHARACTERISTICS $\mathrm{V}_{\mathrm{CCx}}=5.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CCx}}=0.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}$ (Note 9$)$

|  | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Symbol |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{F}_{\text {MAX }}$ | Max Conversion Frequency | 1.3 | 1.6 |  | 1.3 | 1.6 |  | 1.3 | 1.6 |  | Gb/s NRZ |
| $t_{\text {PLH }}$ $t_{\text {tphL }}$ | Propagation Delay to Output <br> CLK to SOUT (Note 10) <br> CLK to CL/4 <br> CLK to CL/8 <br> SYNC to CL/4, CL/8 | $\begin{array}{\|c\|} \hline 1020 \\ 650 \\ 800 \\ 650 \\ \hline \end{array}$ | $\begin{array}{\|c} 1200 \\ 850 \\ 1050 \\ 850 \\ \hline \end{array}$ | $\begin{array}{\|l} 1480 \\ 1050 \\ 1300 \\ 1100 \\ \hline \end{array}$ | $\begin{array}{\|c\|} \hline 1020 \\ 650 \\ 800 \\ 650 \\ \hline \end{array}$ | $\begin{gathered} 1200 \\ 850 \\ 1050 \\ 850 \\ \hline \end{gathered}$ | $\begin{aligned} & 1480 \\ & 1050 \\ & 1300 \\ & 1100 \\ & \hline \end{aligned}$ | $\begin{aligned} & 1020 \\ & 650 \\ & 800 \\ & 650 \\ & \hline \end{aligned}$ | $\begin{array}{\|c} 1200 \\ 850 \\ 1050 \\ 850 \\ \hline \end{array}$ | $\begin{array}{\|l} 1480 \\ 1050 \\ 1300 \\ 1100 \\ \hline \end{array}$ | ps |
| $\mathrm{t}_{\mathrm{s}}$ | Setup Time (Note 11) SIN, Dn | -200 | -450 |  | -200 | -450 |  | -200 | -450 |  | ps |
| $\mathrm{th}^{\text {r }}$ | Hold Time (Note 11) SIN, Dn | 900 | 650 |  | 900 | 650 |  | 900 | 650 |  | ps |
| $\mathrm{t}_{\mathrm{RR}}$ | Reset Recovery Time SYNC | 500 | 300 |  | 500 | 300 |  | 500 | 300 |  | ps |
| tpw | Min Pulse Width CLK, MR | 300 |  |  | 300 |  |  | 300 |  |  | ps |
| $\mathrm{t}_{\text {IITTER }}$ | Random Clock Jitter (RMS) |  | < 1 |  |  | <1 |  |  | <1 |  | ps |
| $\mathrm{V}_{\mathrm{PP}}$ | Input Voltage Swing (Differential Configuration) | 150 |  | 1000 | 150 |  | 1000 | 150 |  | 1000 | mV |
| $\mathrm{t}_{\mathrm{r}}$ $\mathrm{t}_{\mathrm{f}}$ | Rise/Fall Times (20\%-80\%) <br> SOUT Other | $\begin{aligned} & 100 \\ & 200 \end{aligned}$ | $\begin{aligned} & 225 \\ & 425 \end{aligned}$ | $\begin{aligned} & 350 \\ & 650 \end{aligned}$ | 100 | $\begin{aligned} & 225 \\ & 425 \end{aligned}$ | $\begin{aligned} & 350 \\ & 650 \end{aligned}$ | 100 200 | $\begin{aligned} & 225 \\ & 425 \end{aligned}$ | $\begin{aligned} & 350 \\ & 650 \end{aligned}$ | ps |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm . Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.
9. 10 Series: $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.

100 Series: $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
10. Propagation delays measured from negative going clock edge.
11. Relative to negative clock edge.


Figure 3.

## MC10E446, MC100E446



Timing Diagram A. 4:1 Parallel to Serial Conversion


Timing Diagram B. 8:1 Parallel to Serial Conversion
Figure 4. Timing Diagrams

## MC10E446, MC100E446

## Applications Information

The MC10E/100E446 is an integrated 4:1 parallel to serial converter. The chip is designed to work with the E445 device to provide both transmission and receiving of a high speed serial data path. The E446 can convert 4 bits of data into a $1.3 \mathrm{~Gb} / \mathrm{s}$ NRZ data stream. The device features a SYNC input which allows the user to reset the internal clock circuitry and restart the conversion sequence (see timing diagram A ).

The E446 features a differential serial input and internal divide by 8 circuitry to facilitate the cascading of two devices to build a $8: 1$ multiplexer. Figure 1 illustrates the architecture for a $8: 1$ multiplexer using two E446's; the timing diagram for this configuration can be found on the following page. Notice the serial outputs (SOUT) of the higher order converter feed the serial inputs of the the lower order device. This feed through of the serial inputs bounds the upper end of the frequency of operation. The clock to serial output propagation delay plus the setup time of the serial input pins must fit into a single clock period for the cascade architecture to function properly. Using the worst case values for these two parameters from the data sheet, TPD CLK to SOUT $=1480 \mathrm{ps}$ and tS for SIN $=-200 \mathrm{ps}$, yields a minimum period of 1280 ps or a clock frequency of 780 MHz .

The clock frequency is somewhat lower than that of a single converter, to increase this frequency some games can be played with the clock input of the higher order E446. By
delaying the clock feeding E446A relative to the clock of E446B the frequency of operation can be increased.


Figure 5. Cascaded 8:1 Converter Architecture


Figure 6. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020/D - Termination of ECL Logic Devices.)

## ORDERING INFORMATION

| Device | Package | Shipping $^{\dagger}$ |
| :--- | :--- | :--- |
| MC10E446FN | PLCC-28 | 37 Units / Rail |
| MC10E446FNG | PLCC-28 <br> (Pb-Free) | 37 Units / Rail |
| MC10E446FNR2 | PLCC-28 | $500 /$ Tape \& Reel |
| MC10E446FNR2G | PLCC-28 <br> (Pb-Free) | $500 /$ Tape \& Reel |
| MC100E446FN | PLCC-28 | 37 Units / Rail |
| MC100E446FNG | PLCC-28 <br> (Pb-Free) | 37 Units / Rail |
| MC100E446FNR2 | PLCC-28 | $500 /$ Tape \& Reel |
| MC100E446FNR2G | PLCC-28 | (Pb-Free) |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

Resource Reference of Application Notes
AN1405/D - ECL Clock Distribution Techniques
AN1406/D - Designing with PECL (ECL at +5.0 V) $^{\text {AN1503/D }}$ - ECLinPS ${ }^{m}$ I/O SPiCE Modeling Kit
AN1504/D - Metastability and the ECLinPS Family
AN1568/D - Interfacing Between LVDS and ECL
AN1672/D - The ECL Translator Guide
AND8001/D - Odd Number Counters Design
AND8002/D - Marking and Date Codes
AND8020/D - Termination of ECL Logic Devices
AND8066/D - Interfacing with ECLinPS
AND8090/D - AC Characteristics of ECL Devices

## MC10E446, MC100E446

## PACKAGE DIMENSIONS

PLCC-28
FN SUFFIX
PLASTIC PLCC PACKAGE
CASE 776-02
ISSUE E


NOTES

1. DATUMS -L-, -M-, AND -N- DETERMINED WHERE TOP OF LEAD SHOULDER EXITS PLASTIC BODY AT MOLD PARTING LINE.
2. DIMENSION G1, TRUE POSITION TO BE MEASURED AT DATUM -T-, SEATING PLANE
3. DIMENSIONS R AND U DO NOT INCLUDE MOLD FLASH. ALLOWABLE MOLD FLASH IS 0.010 (0.250) PER SIDE
4. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982 .
ANSI Y14.5M, 1982 .
5. THE PACKAGE TOP MAY BE SMALLER THAN

THE PACKAGE BOTTOM BY UP TO 0.012 (0.300). DIMENSIONS R AND U ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY EXCLUSIVE OF MOLD FLASH, TIE BAR BURRS, GATE BURRS AND INTERLEAD FLASH, BUT INCLUDING ANY MISMATCH between the top and bottom Of The PLASTIC BODY.
7. DIMENSION H DOES NOT INCLUDE DAMBAR PROTRUSION OR INTRUSION. THE DAMBAR PROTRUSION OR IN SHALL NOT CAUSE THE H PROTRUSION(S) SHALL NOT CAUSE THE
DIMENSION TO BE GREATER THAN 0.037 DIMENSION TO BE GREATER THAN 0.037
$(0.940)$. THE DAMBAR INTRUSION(S) SHALL ( 0.940 ). THE DAMBAR INTRUSION(S) SH
NOT CAUSE THE HIMENSION TO BE NOT CAUSE THE H DIMENSION
SMALLER THAN 0.025 ( 0.635 ).

|  | INCHE |  |  | MILLIMETERS |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| DIM | MIN | MAX | MIN | MAX |  |
| A | 0.485 | 0.495 | 12.32 | 12.57 |  |
| B | 0.485 | 0.495 | 12.32 | 12.57 |  |
| C | 0.165 | 0.180 | 4.20 | 4.57 |  |
| E | 0.090 | 0.110 | 2.29 | 2.79 |  |
| F | 0.013 | 0.019 | 0.33 | 0.48 |  |
| G | 0.050 | BSC | 1.27 BSC |  |  |
| H | 0.026 | 0.032 | 0.66 | 0.81 |  |
| J | 0.020 | --- | 0.51 | -- |  |
| K | 0.025 | --- | 0.64 | --- |  |
| R | 0.450 | 0.456 | 11.43 | 11.58 |  |
| U | 0.450 | 0.456 | 11.43 | 11.58 |  |
| V | 0.042 | 0.048 | 1.07 | 1.21 |  |
| W | 0.042 | 0.048 | 1.07 | 1.21 |  |
| $\mathbf{X}$ | 0.042 | 0.056 | 1.07 | 1.42 |  |
| Y | --- | 0.020 | --- | 0.50 |  |
| $\mathbf{Z}$ | $2^{\circ}$ | $10^{\circ}$ | $2^{\circ}$ | $100^{\circ}$ |  |
| G1 | 0.410 | 0.430 | 10.42 | 10.92 |  |
| K1 | 0.040 | --- | 1.02 | --- |  |

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